

**256 K × 1 Very Low Power CMOS SRAM**

**Introduction**

The M65697 is a very low power CMOS static RAM organized as 262144 × 1 bit. It is manufactured using the TEMIC high performance CMOS technology named SCMOS.

With this process, TEMIC is the first to bring the solution for applications where fast computing is as mandatory as low consumption, such as aerospace electronics, portable instruments or embarked systems.

Utilizing an array of six transistors (6T) memory cells, the M65697 combines an extremely low standby

supply current (Typical value = 0.1 μA) with a fast access time at 40 ns. The high stability of the 6T cell provides excellent protection against soft errors due to noise.

Extra protection against heavy ions is given by the use of an epitaxial layer of a P substrate.

The M67697 is 100 % processed following the test methods of MIL STD 883 and/or ESA/SCC 9000, making it ideally suitable for military/space applications that demand superior levels of performance and reliability.



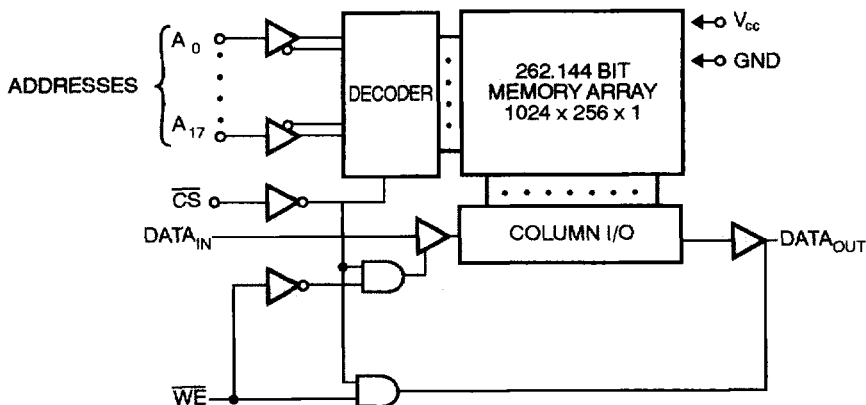
**Features**

- Access time  
commercial : 35(\*), 40, 45, 55 ns  
industrial and military : 40(\*), 45, 55 ns
- Very low power consumption  
active : 50 mW (typ)  
standby : 0.5 μW (typ)  
data retention : 0.4 μW (typ)
- Wide temperature range : -55 to + 125 °C
- 300 mils width package
- TTL compatible inputs and outputs
- Asynchronous
- Single 5 volt supply
- Equal cycle and access time
- Gated inputs : no pull-up/down resistors are required

\* Preliminary. Consult sales.

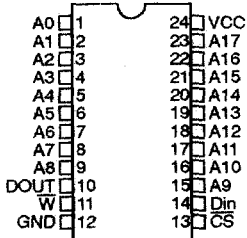
**Interface**

**Block Diagram**



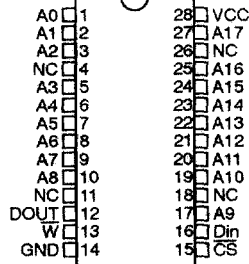
## Pin Configuration

Side Brazed 300 mils 24 pins



(Top View)

SOIC 300 mils 28 pins  
Multilayer Flat Pack 28 pins



(Top View)

## Pin Description

A <sub>0</sub> -A <sub>17</sub> :	Address inputs	CS :	Chip-Select
Din :	Input	W :	Write Enable
:	Output		
V <sub>CC</sub> :	Power		
V <sub>SS</sub> :	Ground		

## Truth Table

CS	W	DATA IN	DATA OUT	MODE
H	X	Z	Z	Deselect/ POWER-DOWN
L	H	Z	Valid	Read
L	L	Valid	Z	Write

L = low, H = high, X = H or L, Z = high impedance

## Electrical Characteristics

### Absolute Maximum Ratings

Supply voltage to GND potential : ..... -0.5 V to + 7.0 V  
Input or Output voltage applied : ..... (Gnd - 0.3 V) to (Vcc + 0.3 V)

Storage temperature : ..... -65 °C to + 150 °C  
Electro static discharge voltage ..... > 1250 V (MIL STD 883,  
METHOD 3015)

### Operating Range

	OPERATING VOLTAGE	OPERATING TEMPERATURE
Military	V <sub>CC</sub> = 5 V ± 10 %	- 55 °C to + 125 °C
Industrial	V <sub>CC</sub> = 5 V ± 10 %	- 40 °C to 85 °C
Commercial	V <sub>CC</sub> = 5 V ± 10 %	0 °C to + 70 °C

### DC Operating Conditions

PARAMETER	DESCRIPTION	MINIMUM	TYPICAL	MAXIMUM	UNIT
V <sub>cc</sub>	Supply voltage	4.5	5.0	5.5	V
Gnd	Ground	0.0	0.0	0.0	V
V <sub>IL</sub> (1)	Input low voltage	- 0.3	0.0	0.8	V
V <sub>IH</sub> (1)	Input high voltage	2.2	-	V <sub>cc</sub> + 0.3	V

Note : 1. V<sub>IH</sub> max = V<sub>cc</sub> + 0.3 V, V<sub>IL</sub> min = -0.3 V or -1.0 pulse 50 ns.

## Capacitance

PARAMETER	DESCRIPTION	MINIMUM	TYPICAL	MAXIMUM	UNIT
Cin (2)	Input capacitance	-	-	8	pF
Cout (2)	Output capacitance	-	-	8	pF

Note : 2. TA = 25°C, f = 1 MHz, Vcc = 5.0 V, these parameters are not tested.

## DC Parameter

PARAMETER	DESCRIPTION	MINIMUM	TYPICAL	MAXIMUM	UNIT
IIX (3)	Input leakage current	- 1.0	-	1.0	μA
IOZ(3)	Output leakage current	- 1.0	-	1.0	μA
VOL (4)	Output low voltage	-	-	0.4	V
VOH (4)	Output high voltage	2.4	-	-	V

Notes : 3. Gnd < Vin < Vcc, Gnd < Vout < Vcc Output disabled.  
4. Vcc min, IOL = 8 mA, IOH = -4 mA.

## Consumption for Commercial Specification

SYMBOL	PARAMETER	M65697 E-30(*)	M65697 V-35(*)	M65697 E-40	M65697 V-40	M65697 E-45	M65697 V-45	M65697 E-50	M65697 V-50	UNIT	VALUE
ICCSB (5)	Standby supply current	10	5	10	5	10	5	10	5	mA	max
ICCSB1 (6)	Standby supply current	75	5	75	5	75	5	75	5	μA	max
ICCOP (7)	Operating supply current	90	70	90	70	90	70	90	70	mA	max

## Consumption for Industrial Specification

SYMBOL	PARAMETER	M65697 E-30(*)	M65697 V-35(*)	M65697 E-40	M65697 V-40	M65697 E-45	M65697 V-45	UNIT	VALUE
ICCSB (5)	Standby supply current	10	5	10	5	10	5	mA	max
ICCSB1 (6)	Standby supply current	100	10	100	10	100	10	μA	max
ICCOP (7)	Operating supply current	90	70	90	70	90	70	mA	max

## Consumption for Military Specification

SYMBOL	PARAMETER	M65697 E-30(*)	M65697 V-35(*)	M65697 E-40	M65697 V-40	M65697 E-45	M65697 V-45	UNIT	VALUE
ICCSB (5)	Standby supply current	10	5	10	5	10	5	mA	max
ICCSB1 (6)	Standby supply current	500	100	500	100	500	100	μA	max
ICCOP (7)	Operating supply current	90	70	90	70	90	70	mA	max

Notes : 5.  $\overline{CS} \geq V_{IH}$ ,  $V_{in} \geq V_{IH}$  or  $V_{in} \leq V_{IL}$ .  
6.  $\overline{CS} \geq V_{cc} - 0.3$  V,  $I_{out} = 0$  mA,  $V_{in} \geq V_{cc} - 0.3$  V or  $V_{in} \leq 0.3$  V.  
7. Vcc max,  $I_{out} = 0$  mA,  $V_{in} = Gnd/V_{cc}$ . Duty cycle 100 %, F = 5 MHz, derating = 10 mA/MHz.  
(\* ) Preliminary. Please consult sales.

## Data Retention Mode

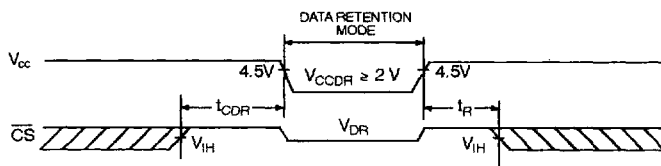
MHS CMOS RAM's are designed with battery backup in mind. Data retention voltage and supply current are guaranteed over temperature. The following rules insure data retention :

1. Chip select ( $\overline{CS}$ ) must be held high during data retention ; within  $V_{CC}$  to  $V_{CC} - 0.2$  V.

2.  $\overline{CS}$  must be kept between  $V_{CC} - 0.3$  V and 70 % of  $V_{CC}$  during the power up and power down transitions.

4. The RAM can begin operation > 45 ns after  $V_{CC}$  reaches the minimum operating voltage (4.5 V).

## Timing



## Data Retention Characteristics

PARAMETER	DESCRIPTION	MINIMUM	TYPICAL (3)	MAXIMUM			UNIT
VCCDR	$V_{CC}$ for data retention	2.0	-	-			V
TCDR	Chip deselect to data retention time	0.0	-	-			ns
TR	Operation recovery time	TAVAV (9)	-	-			ns
ICCDR1 (10)	Data retention current			COM	IND	MIL	
	@ 2.0 V : M-65697 V M-65697 L	- -	0.1 0.1	3 60	8 80	80 300	$\mu$ A $\mu$ A
ICCDR2 (10)	Data retention current						
	@ 3.0 V : M-65697 V M-65697 L	- -	0.3 0.3	4 70	9 90	90 400	$\mu$ A $\mu$ A

Notes : 8.  $T_A = 25^\circ\text{C}$ .

9. TAVAV = Read cycle time.

10.  $\overline{CS} = V_{CC}$ ,  $V_{in} = \text{Gnd}/V_{CC}$ , this parameter is only tested at  $V_{CC} = 2$  V.

**AC Parameters**

**AC Conditions :**

Input pulse levels : ..... Gnd to 3.0 V      Input timing reference levels : ..... 1.5 V  
 Input rise : ..... 5 ns      Output load : ..... See fig. 1a, 1b



**Write Cycle : Commercial Specification (note 12)**

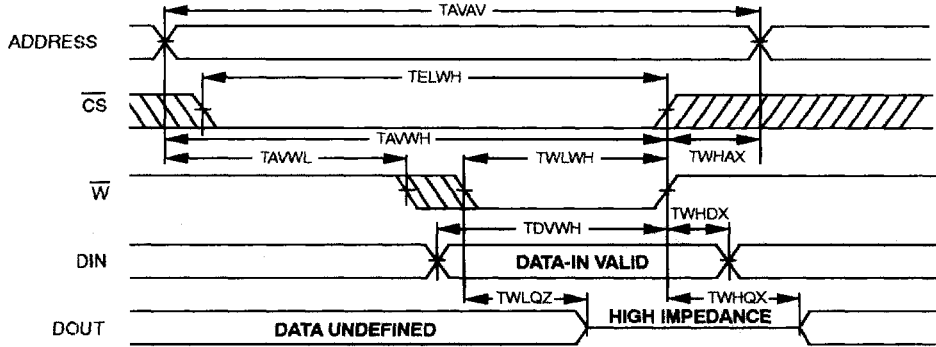
SYMBOL	PARAMETER	M65697 I/V - 30%	M65697 I/V - 40	M65697 I/V - 45	M65697 I/V - 55	UNIT	VALUE
TAVAV	Write cycle time	35	40	45	55	ns	min
TAVWL	Address set-up time	0	0	0	0	ns	min
TAVWH	Address valid to end of write	30	30	40	50	ns	min
TDVWH	Data set-up time	20	22	25	25	ns	min
TELWH	$\overline{CS}$ low to write end	30	30	40	50	ns	min
TWLQZ (11)	Write low to high Z	15	15	15	20	ns	max
TWLWH	Write pulse width	30	30	40	50	ns	min
TWHAX	Address hold to end of write	0	0	0	0	ns	min
TWHDX	Data hold time	0	0	0	0	ns	min
TWHQX (11)	Write high to low Z	0	0	0	0	ns	min

**Write Cycle : Industrial and Military Specification (note 12)**

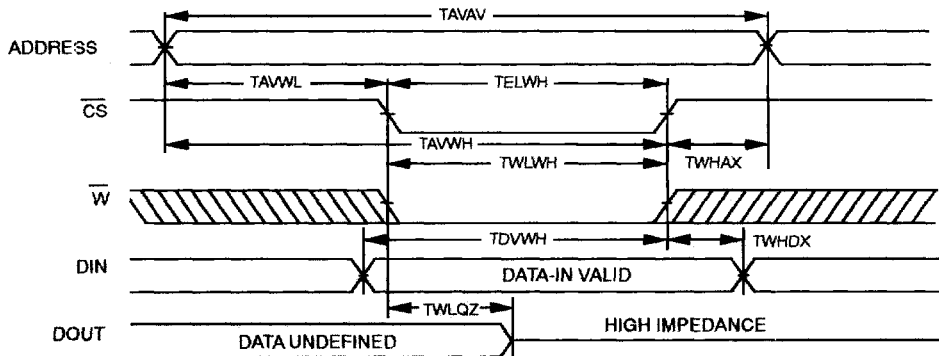
SYMBOL	PARAMETER	M65697 I/V - 40%	M65697 I/V - 45	M65697 I/V - 55	UNIT	VALUE
TAVAV	Read cycle time	40	45	55	ns	min
TAVWL	Address set-up time	0	0	0	ns	min
TAVWH	Address valid to end of write	30	40	50	ns	min
TDVWH	Data set-up time	22	25	25	ns	min
TELWH	$\overline{CS}$ low to write end	30	40	50	ns	min
TWLQZ (11)	Write low to high Z	15	15	20	ns	min
TWLWH	Write pulse width	30	40	50	ns	min
TWHAX	Address hold to end of write	0	0	0	ns	min
TWHDX	Data hold time	0	0	0	ns	min
TWHQX (11)	Write high to low Z	0	0	0	ns	min

Notes : 11. Specified with  $C_L = 5 \text{ pF}$  (see figure 1b). Guaranteed. Not tested.  
 (\*) Preliminary. Consult sales.

## Write Cycle 1 : $\overline{W}$ Controlled (note 12)



## Write Cycle 2 : $\overline{CS}$ Controlled (note 12)



**Note :** 12. The internal write time of the memory is defined by the overlap of  $\overline{CS}$  LOW and  $\overline{W}$  LOW. Both signals must be LOW to initiate a write and either signal can terminate a write by going HIGH. The data input setup and hold timing should be referenced to the rising edge of the signal that terminates the write.

## AC Test Loads and Waveforms

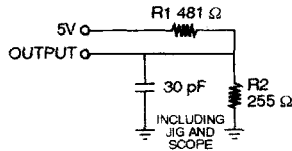


Figure 1 a

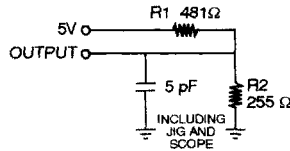


Figure 1 b

Equivalent to : THEVENIN EQUIVALENT

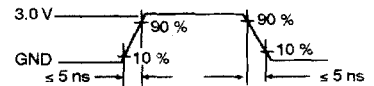
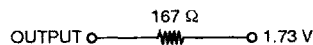


Figure 2

## Read Cycle : Commercial Specification

SYMBOL	PARAMETER	M65697 L/V - 33(*)	M65697 L/V - 40	M65697 L/V - 45	M65697 L/V - 55	UNIT	VALUE
TAVAV	Write cycle time	35	40	45	55	ns	min
TAVQV	Address access time	35	40	45	55	ns	max
TAVQX	Address valid to low Z	5	5	5	5	ns	min
TELQV	Chip-select access time	35	40	45	55	ns	max
TELQX (13)	$\overline{CS}$ low to low Z	5	5	5	5	ns	min
TEHQZ (13)	$\overline{CS}$ high to high Z	20	20	20	20	ns	max

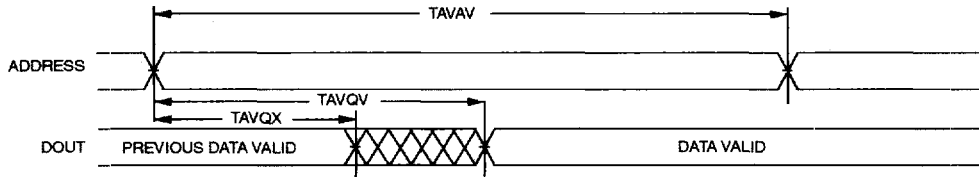
## Read Cycle : Industrial and Military Specification

SYMBOL	PARAMETER	M65697 L/V - 40(*)	M65697 L/V - 45	M65697 L/V - 55	UNIT	VALUE
TAVAV	Read cycle time	40	45	55	ns	min
TAVQV	Address access time	40	45	55	ns	max
TAVQX	Address valid to low Z	5	5	5	ns	min
TELQV	Chip-select access time	40	45	55	ns	max
TELQX (13)	$\overline{CS}$ low to low Z	5	5	5	ns	min
TEHQZ (13)	$\overline{CS}$ high to high Z	20	20	20	ns	max

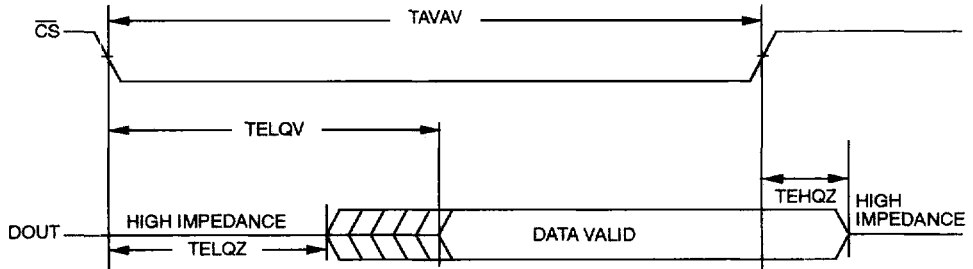
Notes : 13. Specified with CL = 5 pF (see figure 1b). Guaranteed but not tested.

(\*) Preliminary. Consult sales.

## Read Cycle nb 1 (notes 14, 15)



## Read Cycle nb 2 (notes 14, 16)



- Notes :
- 14.  $\bar{W}$  is high for read cycle.
  - 15. Device is continuously selected  $\bar{CS} = \text{VIL}$ .
  - 16. Address valid prior to or coincident with  $\bar{CS}$  transition low.



## Ordering Information

TEMPERATURE RANGE	PACKAGE	DEVICE	GRADE	SPEED	FLOW
<b>C</b>	<b>M</b>	<b>TI</b>	<b>- 65697</b>	<b>V</b>	<b>- 45</b>
C = Commercial I = Industrial M = Military S = Space	0° to +70°C -40° to +85°C -55° to +125°C -59° to +125°C	256K x 1 STATIC RAM	V = Very low power L = Low power	35 ns 40 ns 45 ns 55 ns	blank = MHS Standards /883 = MIL STD 883 Class B or S P883 = MIL STD 883 + PIND test SB/SC = SCC 9000 level B/C SHXXX = Special customer request FHXXX = Flight models (space) EHXXX = Engineering models (space) MHXXX = Mechanical parts (space) LHXXX = Life test parts (space) :R = Tape and Reel :RD = Tape & Reel and Dry Pack :D = Dry Pack
	CZ = 24 pins DIL SIDE-BRAZED 300 mils DP = 28 pins Multilayer Flat Pack TI = 28 pins SOIC 300 mils 0 = die				



## Military and Space Versions

The following table gives package/consumption/access time/process flow available combinations

Temp. range	Package	Consumption		Access Time (ns)			S64 process 65697	RT process 65697	
		V	L	40	45	55	Mil flows	Mil flows	Space flows (including SCC9301038)
M	CZ	●	●	X	●	●	●		
	DP	X	X	X	X	X	X		
	0	X	●	X	X	●	●		
S	CZ	●		X	●	●		●	●
	DP	X		X	X	X		X	X
	0	X	●	X	X	●		●	●

● = product in production

X = call sales office for availability

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